

## 20A 650V N-channel Enhancement Mode Power MOSFET

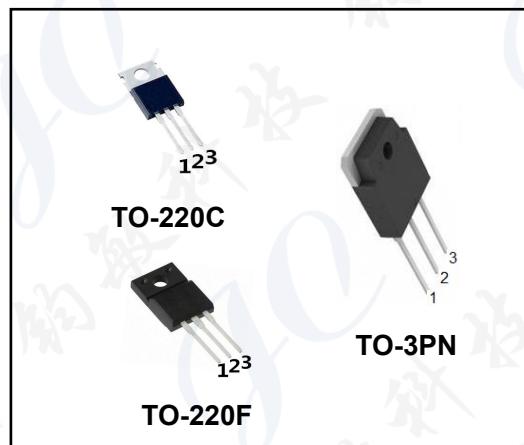
### 1 Description

These silicon N-channel enhanced vdmosfets are obtained by the self-aligned planar technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The package form is TO-220F. Which accords with the RoHS standard.

	$V_{DSS} = 650V$ $R_{DS(on)}(TYP) = 0.35\Omega$ $I_D = 20A$
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### 2 Features

- Fast switching
- Low on resistance( $R_{DS(on)} \leq 0.5\Omega$ )
- Low gate charge(Typ: 57.7nC)
- Low reverse transfer capacitances(Typ: 167pF)
- 100% single pulse avalanche energy test
- 100%  $\Delta V_{DS}$  test



### 3 Application

- Used in various power switching circuit for system miniaturization and higher efficiency.
- Power switch circuit of adaptor and charger.

### 4 Electrical Characteristics

#### 4.1 Absolute Maximum Rating ( $T_c=25^\circ C$ , unless otherwise noted)

Parameter	Symbol	Value			Units
		20N65AQ1	F20N65AQ1	20N65DAQ1	
Maximum Drian-Source DC Voltage	$V_{DSS}$	650			V
Maximum Gate-Drain Voltage	$V_{GSS}$		$\pm 30$		V
Drain Current(continuous)	$I_D$	20			A
		14			A
Drain Current(Pulsed)	$I_{DM}$	80			A
Single Pulse Avalanche Energy	$E_{AS}$	810			mJ
Peak Diode Recovery dv/dt	dv/dt	5			V/ns
Total Dissipation	$P_{tot}$	2	2	3	W
	$P_{tot}$	250	85	250	W
Junction Temperature	$T_j$	150			°C
storage Temperature	$T_{stg}$	-55~150			°C
High Temperature(tin solder)	$T_L$	300			°C

#### 4.2 Thermal Characteristics

Parameter	Symbol	Value			Unit
		20N65AQ1	F20N65AQ1	20N65DAQ1	
Thermal Resistance Junction to Case-sink	$R_{thJC}$	0.5	1.47	0.5	°C/W
Thermal Resistance Junction to Ambient	$R_{thJA}$	62.5	62.5	41.7	°C/W

**4.3 Electrical Characteristics (T<sub>c</sub>=25°C, unless otherwise noted)**

Parameter	Symbol	Test Condition	Value			Units
			Min	Typ	Max	
<b>Off Characteristics</b>						
Drain-source Breakdown Voltage	BV <sub>DSS</sub>	I <sub>D</sub> =250μA,V <sub>GS</sub> =0V	650	680	--	V
Drain-to-Source Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> =650V,V <sub>GS</sub> =0V,T <sub>c</sub> =25°C	--	--	1	μA
		V <sub>DS</sub> =520V,V <sub>GS</sub> =0V,T <sub>c</sub> =125°C	--	--	100	μA
Gate-to-Source Forward Leakage	I <sub>GSSF</sub>	V <sub>GS</sub> =+30V	--	--	100	nA
Gate-to-Source Reverse Leakage	I <sub>GSSR</sub>	V <sub>GS</sub> =-30V	--	--	-100	nA
<b>On Characteristics</b>						
Gate threshold voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =250μA	2.0	--	4.0	V
Drain-source on Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =10V,I <sub>D</sub> =10A	--	0.35	0.5	Ω
Forward Transconductance	g <sub>fs</sub>	V <sub>DS</sub> =15V,I <sub>D</sub> =10A	--	15.5	--	S
<b>Dynamic Characteristics</b>						
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> =0V,V <sub>DS</sub> =25V,f=1.0MHz	--	3021	--	pF
Output Capacitance	C <sub>oss</sub>		--	199	--	
Reverse Transfer Capacitance	C <sub>rss</sub>		--	167	--	
Gate Resistance	R <sub>G</sub>	V <sub>DS</sub> =0V,V <sub>GS</sub> =0V,F=1MHz	--	2.5	--	Ω
<b>Switching Characteristics</b>						
Turn-on Delay Time	t <sub>d(on)</sub>	I <sub>D</sub> =20A, V <sub>DD</sub> =325V, R <sub>G</sub> =25Ω	--	24.4	--	nS
Turn-on Rise Time	t <sub>r</sub>		--	29.4	--	
Turn-off Delay Time	t <sub>d(off)</sub>		--	76.8	--	
Turn-off Fall Time	t <sub>f</sub>		--	36.8	--	
Total Gate Charge	Q <sub>g</sub>	I <sub>D</sub> =20A,V <sub>DD</sub> =325V,V <sub>GS</sub> =10V	--	57.7	--	nC
Gate-to-Source Charge	Q <sub>gs</sub>		--	19.5	--	
Gate-to-Drain("Miller")Charge	Q <sub>gd</sub>		--	15.3	--	
<b>Drain-Source Diode Characteristics</b>						
Diode Forward Voltage	V <sub>FSD</sub>	V <sub>GS</sub> =0V,I <sub>s</sub> =20A	--	--	1.5	V
Diode Forward Current	I <sub>s</sub>	T <sub>J</sub> =25°C,I <sub>F</sub> =20A, dI <sub>F</sub> /dt=100A/μs,V <sub>GS</sub> =0V	--	--	20	A
Reverse Recovery Time	t <sub>rr</sub>		--	574	--	nS
Reverse Recovery Charge	Q <sub>rr</sub>		--	7244	--	nC

**Notes:**

- 1: Repetitive rating, pulse width limited by maximum junction temperature.
- 2: Surface mounted on FR4 Board, t≤10sec.
- 3: Pulse width ≤ 300μs, duty cycle ≤ 2%.
- 4: Guaranteed by design, not subject to production.
- 5: L=10mH,I<sub>D</sub>=18A,V<sub>DD</sub>=50V,V<sub>GATE</sub>=650V,Start T<sub>J</sub>=25°C.
6. I<sub>SD</sub>=20A,di/dt≤200A/μs,V<sub>DD</sub>≤BV<sub>DSS</sub>, Start T<sub>J</sub>=25°C.

## 5 Typical characteristics diagrams

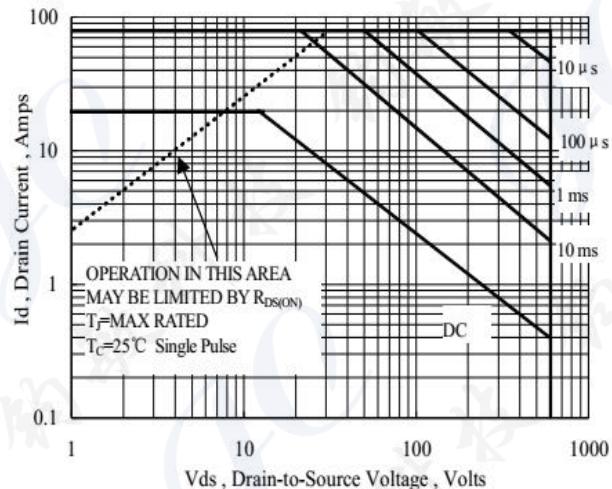


Figure 1 Maximum Forward Bias Safe Operating Area

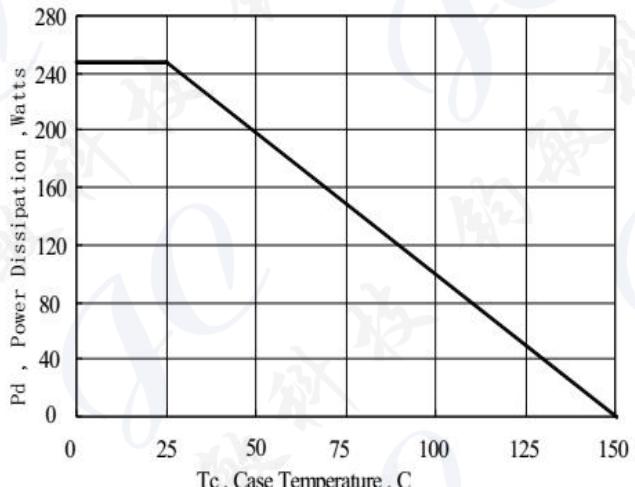


Figure 2 Maximum Power Dissipation vs Case Temperature

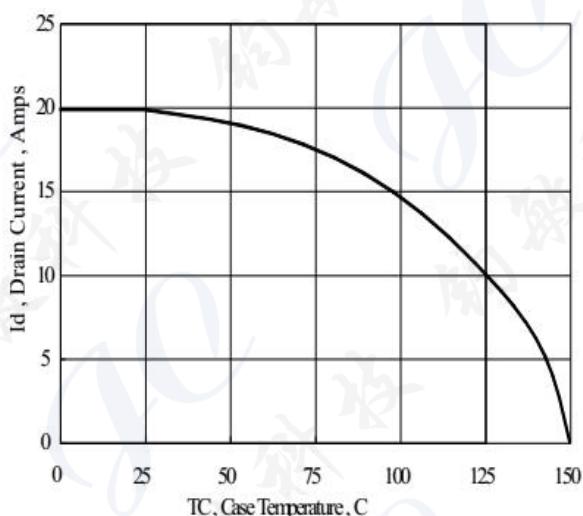


Figure 3 Maximum Continuous Drain Current vs Case Temperature

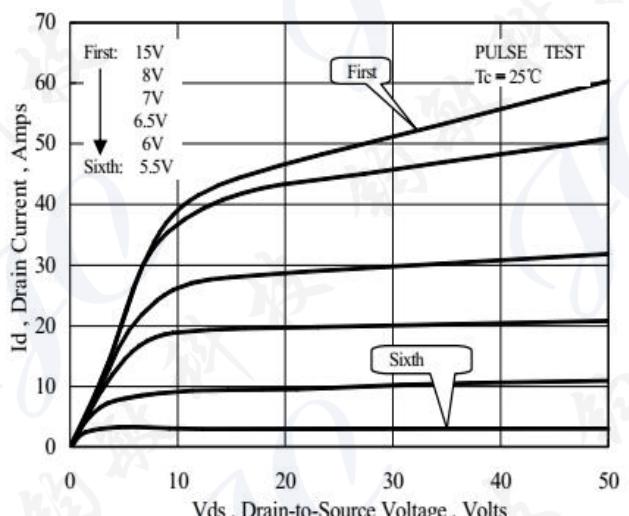


Figure 4 Typical Output Characteristics

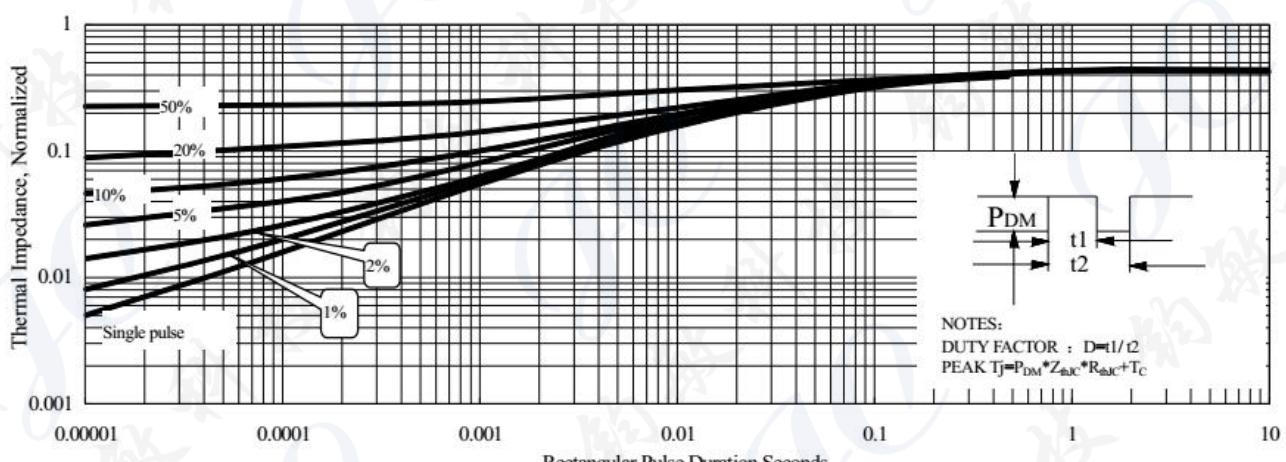


Figure 5 Maximum Effective Thermal Impedance , Junction to Case

## 5 Typical characteristics diagrams(continues)

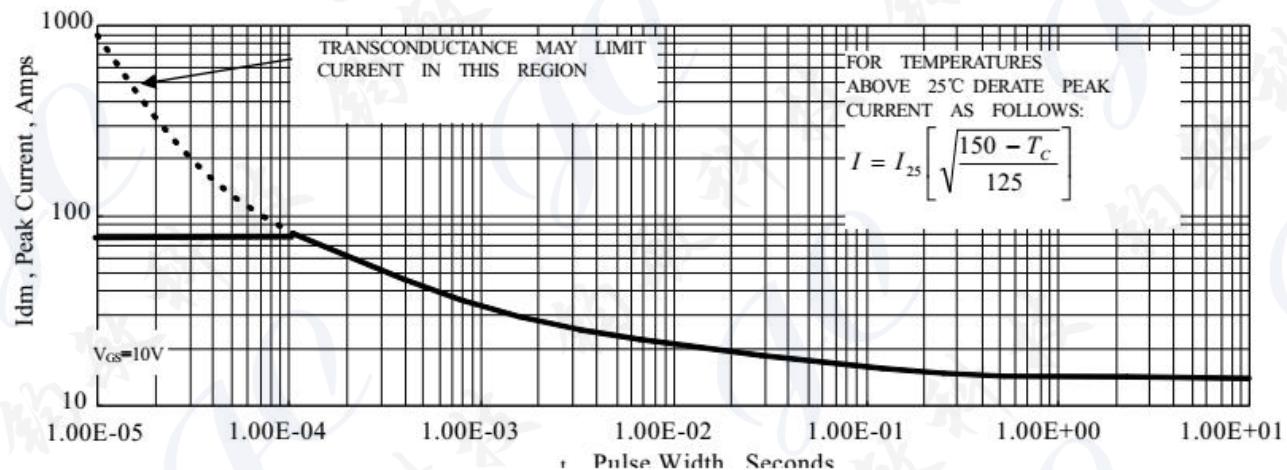


Figure 6 Maximum Peak Current Capability

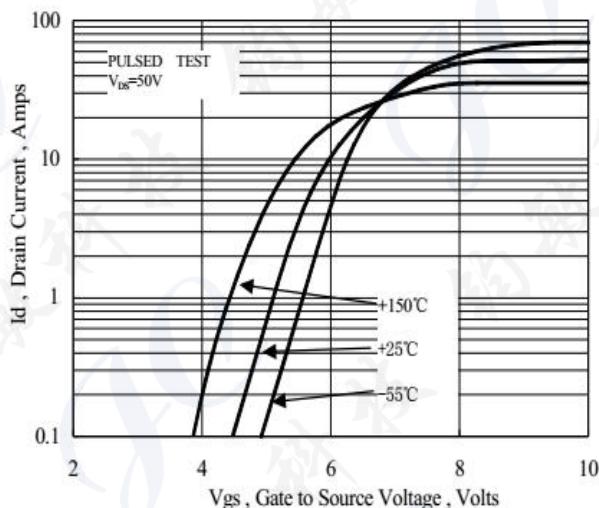


Figure 7 Typical Transfer Characteristics

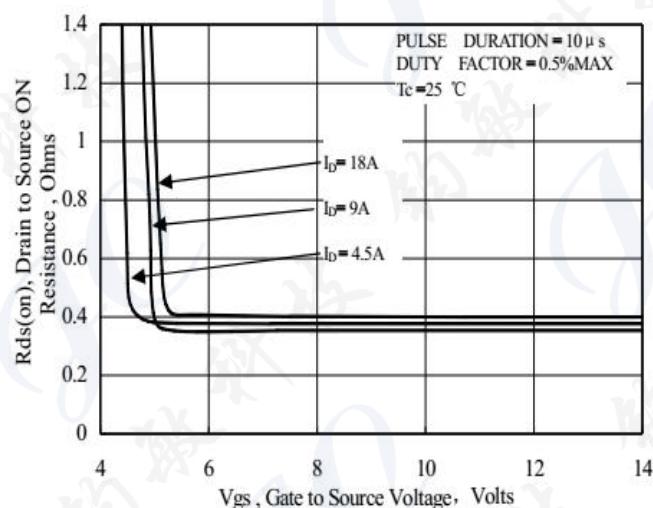


Figure 8 Typical Drain to Source ON Resistance vs Gate Voltage and Drain Current

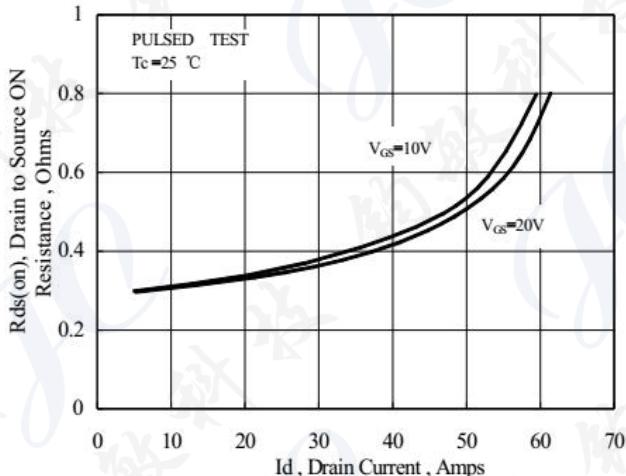


Figure 9 Typical Drain to Source ON Resistance vs Drain Current

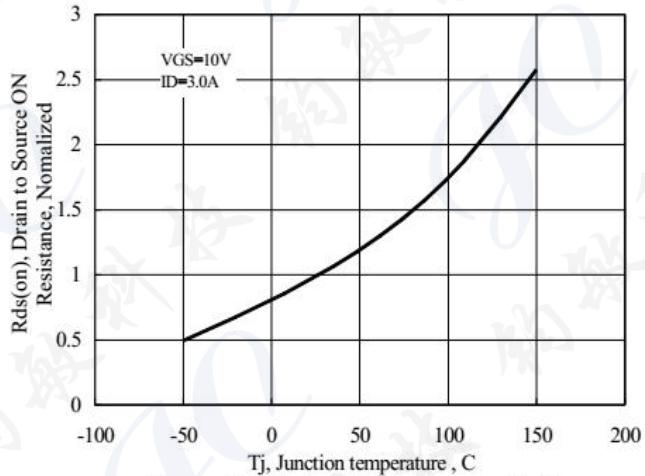
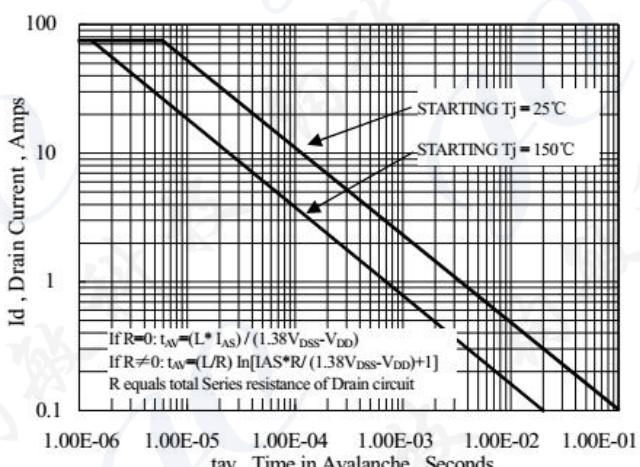
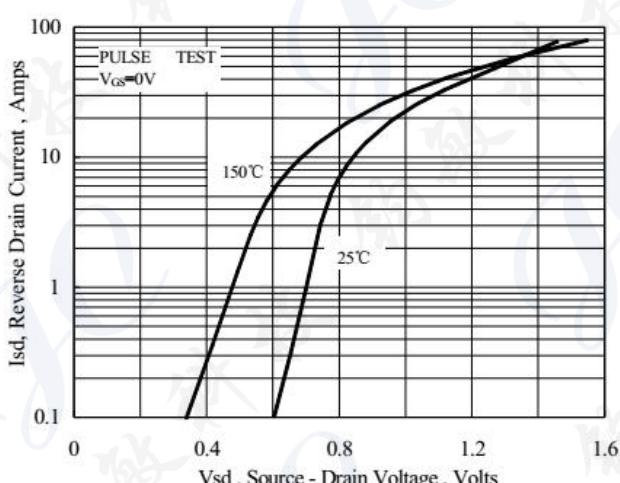
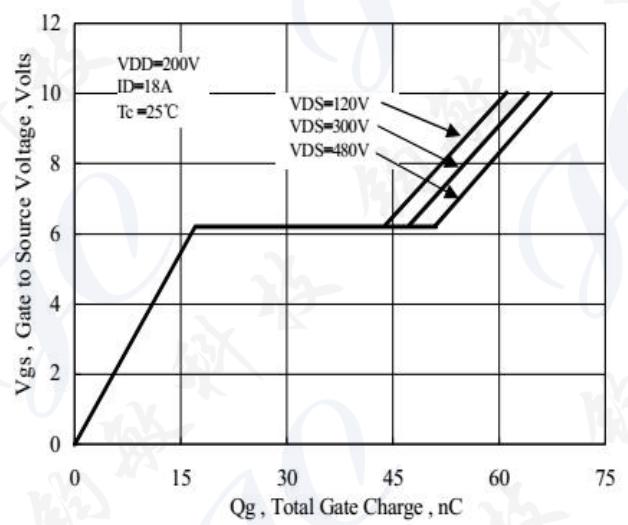
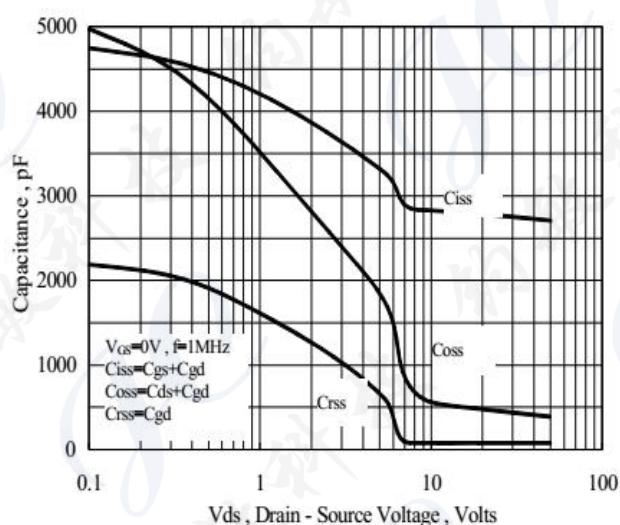
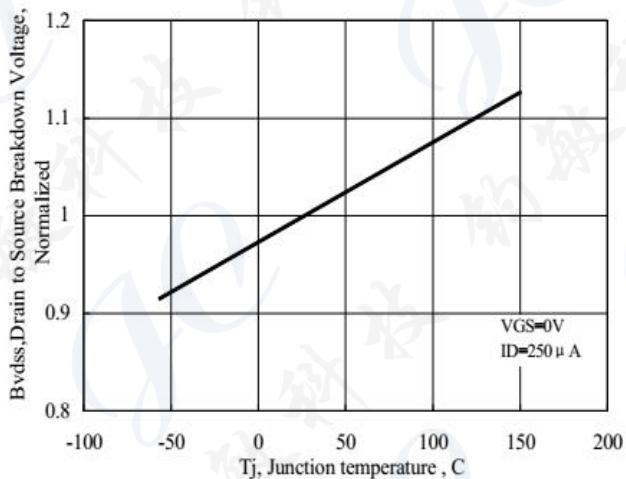
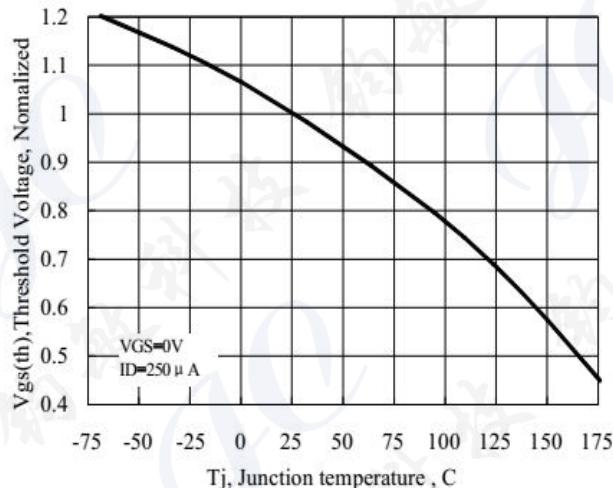


Figure 10 Typical Drian to Source on Resistance vs Junction Temperature

## 5 Typical characteristics diagrams(continues)



## 5 Typical characteristics diagrams(continues)

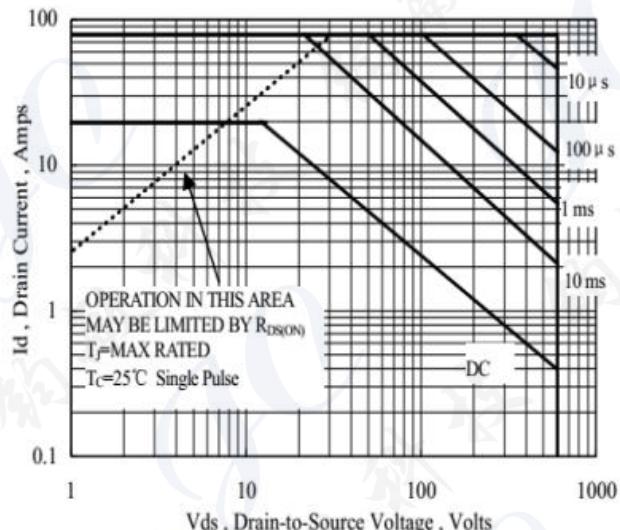


Figure 17 Maximum Forward Bias Safe Operating Area

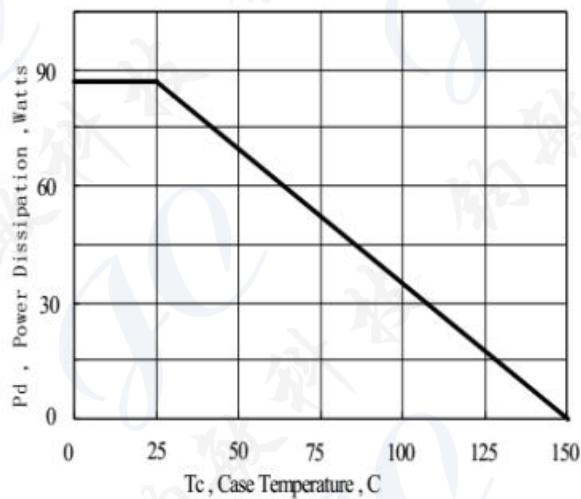
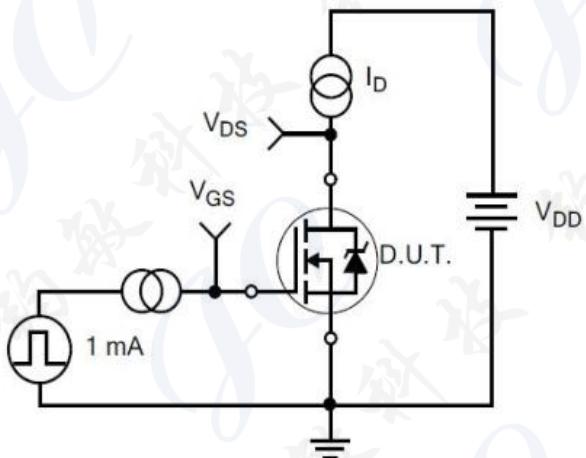
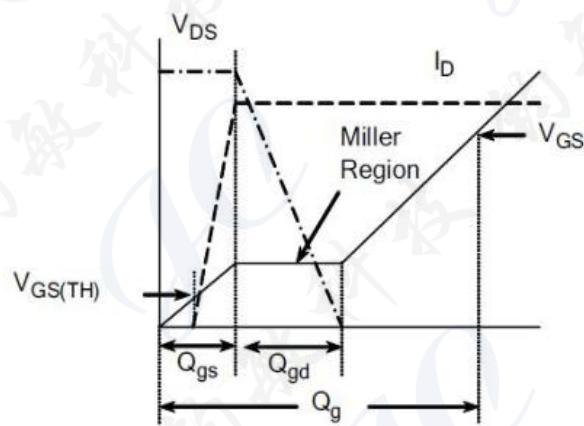


Figure 18 Maximum Power Dissipation vs Case Temperature

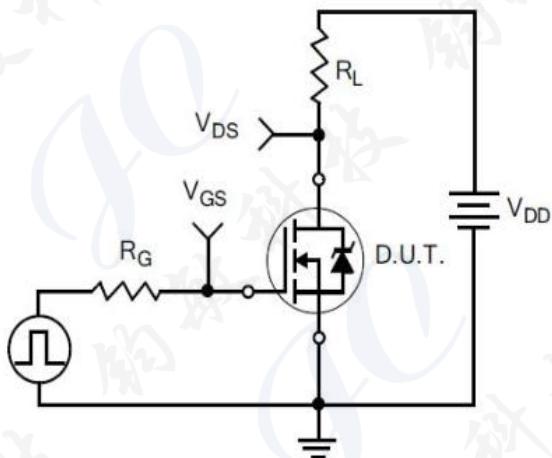
## 6 Typical Test Circuit and Waveform



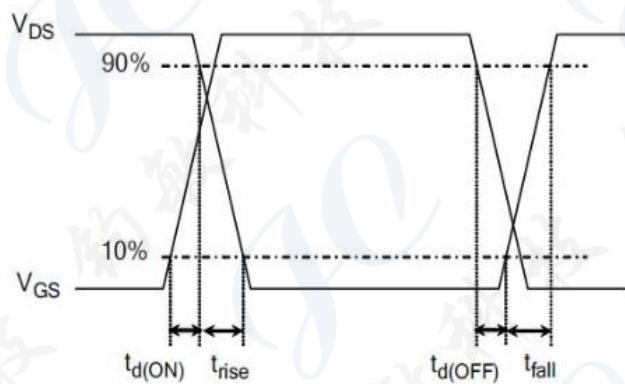
1) Gate Charge Test Circuit



2) . Gate Charge Waveform

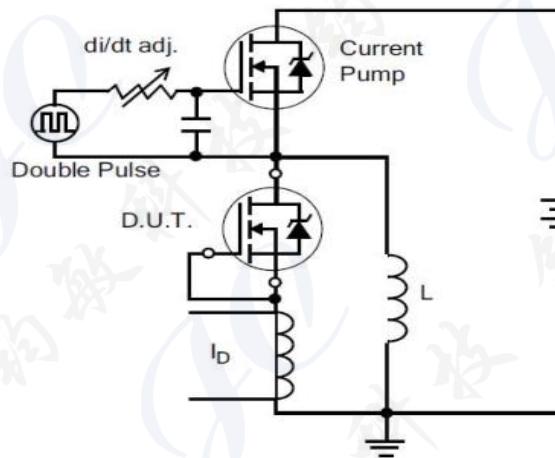


3) Resistive Switching Test Circuit

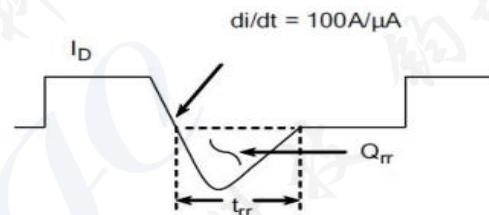


4) Resistive Switching Waveforms

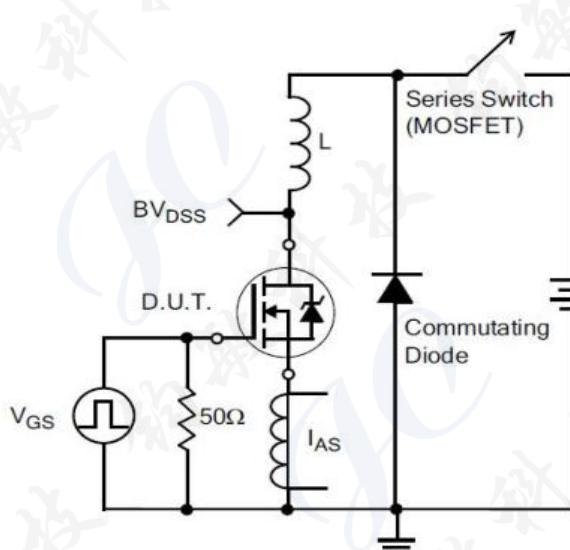
## 6 Typical Test Circuit and Waveform(continues)



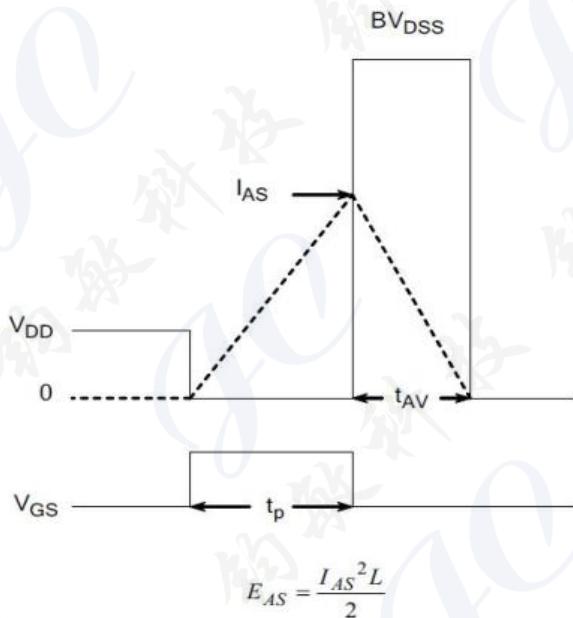
5) Diode Reverse Recovery Test Circuit



6) Diode Reverse Recovery Waveform

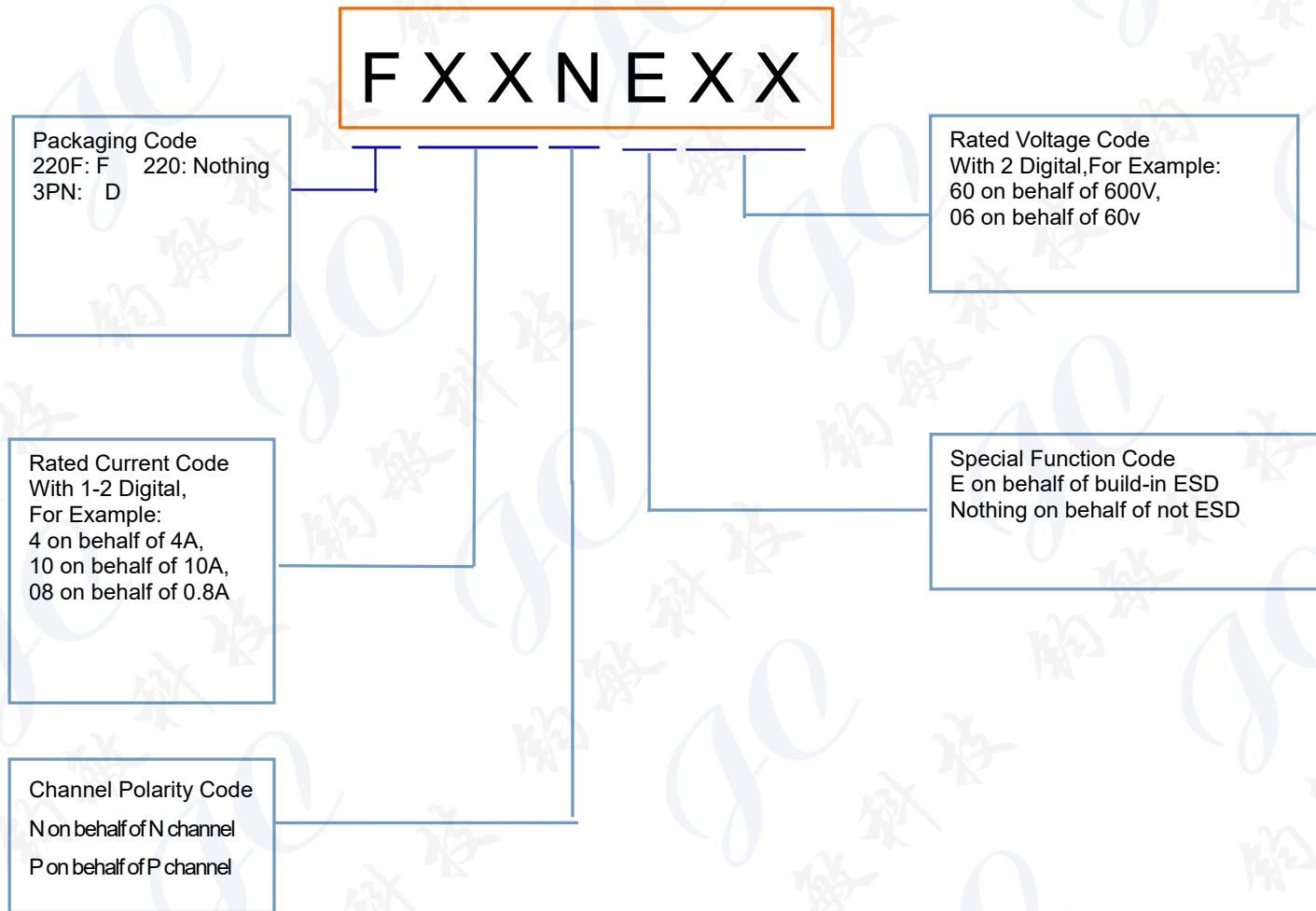


7) Unclamped Inductive Switching Test Circuit



8) Unclamped Inductive Switching Waveforms

## 7 Product Names Rules

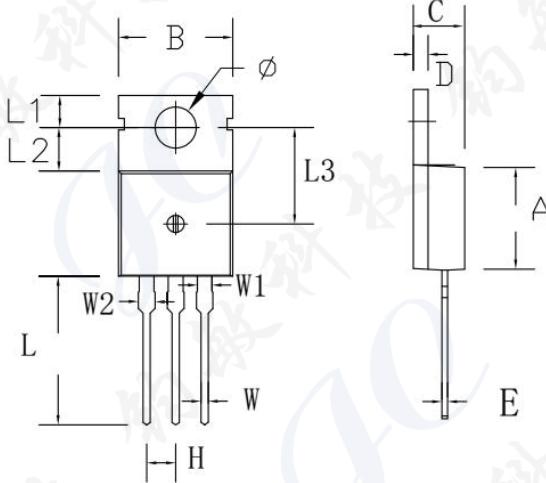


## 8 Product Specifications and Packaging Models

Product Model	Package Type	Mark Name	Identification Code	RoHS	Package	Quantity
20N65AQ1	TO-220C	20N65	AQ1	Pb-free	Tube	1000/box
F20N65AQ1	TO-220F	F20N65	AQ1	Pb-free	Tube	1000/box
20N65DAQ1	TO-3PN	20N65D	AQ1	Pb-free	Tube	600/box

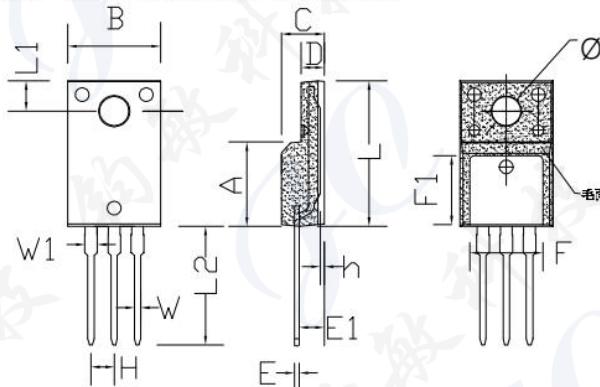
## 9 Dimensions

TO-220C PACKAGE OUTLINE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	min.	max.	min.	max.
A	8.80	9.30	0.346	0.366
B	9.70	10.30	0.382	0.406
C	4.25	4.75	0.167	0.187
D	1.20	1.45	0.047	0.057
E	0.40	0.60	0.016	0.024
H	2.54 TYP		0.100 TYP	
W	0.60	0.95	0.024	0.037
W1	1.05	1.45	0.041	0.057
W2	1.20	1.60	0.047	0.063
L	12.60	13.40	0.496	0.528
L1	2.45	2.95	0.096	0.116
L2	3.45	3.95	0.136	0.156
L3	8.15	8.65	0.321	0.341
Φ	3.50	3.90	0.138	0.154

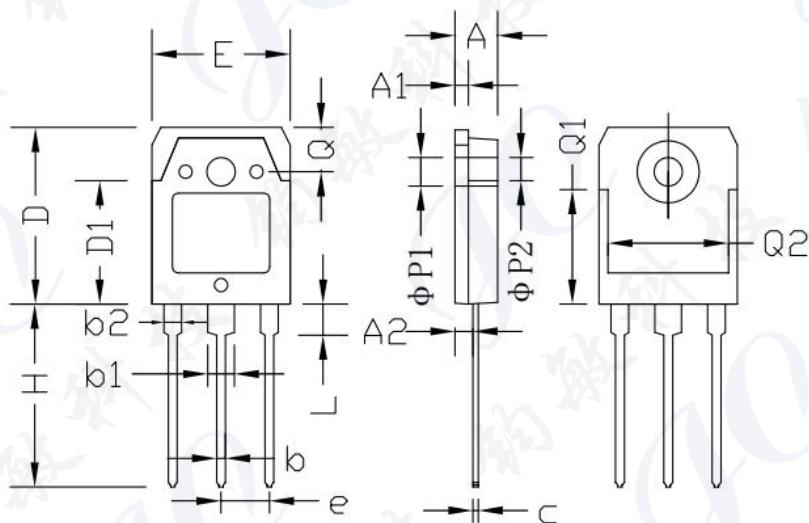
TO-220F PACKAGE OUTLINE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	min.	max.	min.	max.
A	8.80	9.30	0.346	0.366
B	10.00	10.50	0.394	0.413
C	4.30	4.90	0.169	0.193
D	2.30	2.70	0.091	0.106
L	15.55	16.15	0.612	0.636
h	0.40	0.60	0.016	0.024
L1	3.15	3.55	0.124	0.140
L2	12.65	13.35	0.498	0.526
W	0.70	0.90	0.028	0.035
W1	1.15	1.55	0.045	0.061
H	2.54 TYP		0.100 TYP	
E	0.48	0.53	0.019	0.021
Φ	2.90	3.40	0.114	0.134
E1	2.40	2.90	0.094	0.114
F	7.75	8.25	0.305	0.325
F1	7.35	7.85	0.289	0.309

## 9 Dimensions(continues)

TO-3PN PACKAGE OUTLINE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	min.	max.	min.	max.
A	4.60	5.00	0.181	0.197
A1	1.45	1.65	0.057	0.065
A2	2.20	2.60	0.087	0.102
b	0.80	1.20	0.032	0.047
b1	2.80	3.20	0.110	0.126
b2	1.80	2.20	0.071	0.087
C	0.55	0.75	0.022	0.030
D	19.20	19.70	0.756	0.776
D1	13.10	14.70	0.516	0.578
E	15.40	15.80	0.607	0.623
e	5.45	TYP	0.215	TYP
H	19.80	20.20	0.780	0.826
L	3.30	3.70	0.130	0.146
ΦP1	3.20	TYP	0.126	TYP
ΦP2	3.50	TYP	0.138	TYP
Q	5.00	TYP	0.197	TYP
Q1	12.40	TYP	0.488	TYP
Q2	12.6	-	0.496	-

## 10 Attenions

- Jiangsu Donghai Semiconductor Technology CO.,LTD. reserves the right to change the specification without prior notice! The customer should obtain the latest version of the information before making the order and verify that the information is complete and up to date.
- It is the responsibility of the purchaser for any failure or failure of any semiconductor product under certain conditions. It is the responsibility of the purchaser to comply with safety standards and to take safety measures in the system design and machine manufacturing of Donghai products in order to avoid potential risk of failure. Injury or property damage.
- Product promotion is endless, our company will be dedicated to provide customers with better products.

## 11 Appendix

Revision history:

Date	REV.	Description	Page
2017.03.09	1.0	Original	